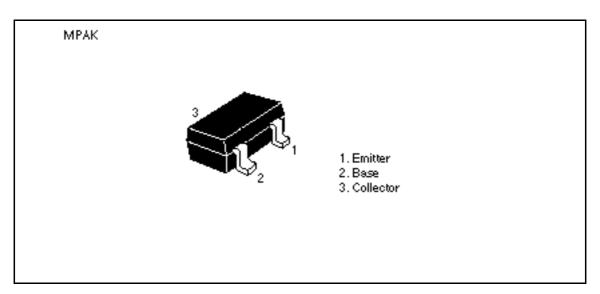
Silicon PNP Epitaxial

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Application

- Low frequency amplifier
- Complementary pair with 2SC2618

Outline





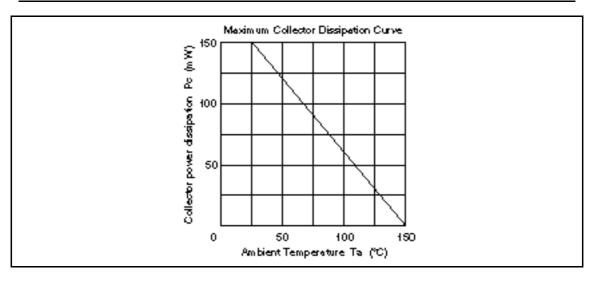
Absolute Maximum Ratings (Ta = 25° C)

Item	Symbol	Ratings	Unit
Collector to base voltage	V _{CBO}	-35	V
Collector to emitter voltage	V _{CEO}	-35	V
Emitter to base voltage	V _{EBO}	-4	V
Collector current	I _c	-500	mA
Collector power dissipation	Pc	150	mW
Junction temperature	Тј	150	°C
Storage temperature	Tstg	–55 to +150	°C

Electrical Characteristics (Ta = 25° C)

ltem		Symbol	Min	Тур	Мах	Unit	Test conditions	
Collector to voltage	base breakdown	$V_{(BR)CBO}$	-35	_	_	V	$I_{c} = -10 \ \mu A, \ I_{e} = 0$	
Collector to emitter breakdown voltage		$V_{(\text{BR})\text{CEO}}$	-35	_	-	V	$I_c = -1$ mA, $R_{BE} =$	
Emitter to b voltage	base breakdown	$V_{(\text{BR})\text{EBO}}$	-4	_	_	V	$I_{\rm E} = -10 \ \mu A, \ I_{\rm C} = 0$	
Collector c	utoff current	I _{CBO}	_	_	-0.5	μA	$V_{CB} = -20 \text{ V}, \text{ I}_{E} = 0$	
Collector to voltage	emitter saturation	$V_{\text{CE(sat)}}$	_	-0.2	-0.6	V	$I_{c} = -150 \text{ mA}, I_{B} = -15 \text{ mA}$	
DC current transfer ratio		h _{FE} *1	60	—	320		$V_{ce} = -3 \text{ V}, \text{ I}_{c} = -10 \text{ mA}$	
		h _{FE}	10	_	_		$V_{ce} = -3 V$, $I_c = -500 mA$ (Pulse test)	
Base to emitter voltage		V_{BE}	—	-0.64	—	V	$V_{ce} = -3 \text{ V}, \text{ I}_{c} = -10 \text{ mA}$	
Note: 1. The 2SA1121 is grouped by h _{FE} as follows.								
Grade	B C	;	D					
Mark	SB S	C	SD					
h _{FE}	60 to 120 1	00 to 200	160 to	320				

See characteristic curves of 2SA673.



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